

**Notice of References Cited**

Application/Control No.

09/788,669

Applicant(s)/Patent Under  
Reexamination  
KAHN ET AL.

Examiner

John M. Villecco

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,674,468	01-2004	Hosoe et al.	348/333.02
	B	US-6,564,282	05-2003	Torres, Daniel J.	711/1
	C	US-6,188,431	02-2001	Oie, Masahiro	348/211.5
	D	US-6,549,307	04-2003	Makishima et al.	348/333.11
	E	US-5,764,800	06-1998	Yamagata, Naoki	348/231.7
	F	US-2002/0033960	03-2002	Kazami, Kazuyuki	358/1.14
	G	US-6,301,392	10-2001	Acharya, Tinku	348/231.1
	H	US-2003/0221081	11-2003	Torres, Daniel J.	711/171
	I	US-2002/0118285	08-2002	Misawa et al.	348/231.2
	J	US-2003/0071900	04-2003	Aoyagi, Yoshiro	348/207.1
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10334261 A	12-1998	Japan	SANO, JUNPEI	G06T 11/80
	O	JP 10084343 A	03-1998	Japan	YANO et al.	H04L 12/28
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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